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ARTICLE OPEN Multiscale simulations of growth-dominated Sb₂Te phasechange material for non-volatile photonic applications

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Chalcogenide phase-change materials (PCMs) are widely applied in electronic and photonic applications, such as non-volatile memory and neuro-inspired computing. Doped Sb₂Te alloys are now gaining increasing attention for on-chip photonic applications, due to their growth-driven crystallization features. However, it remains unknown whether Sb₂Te also forms a metastable crystalline phase upon nanoseconds crystallization in devices, similar to the case of nucleation-driven Ge-Sb-Te alloys. Here, we carry out ab initio simulations to understand the changes in optical properties of amorphous Sb₂Te upon crystallization and post annealing. During the continuous transformation process, changes in the dielectric function are highly wavelength-dependent from the visible-light range towards the telecommunication band. Our finite-difference time-domain simulations based on the ab initio input reveal key differences in device output for color display and photonic memory applications upon tellurium ordering. Our work serves as an example of how multiscale simulations of materials can guide practical photonic phase-change applications.

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INTRODUCTION

Chalcogenide phase change materials (PCMs) can rapidly and reversibly switch between crystalline and amorphous phases. The large difference in atomic structure and bonding mechanism between the two phases gives rise to a notable contrast in electrical and optical properties, which can be used to encode digital data¹⁻¹⁰. The invention of the very first successful product based on PCMs can be traced back to the 1990s, when rewritable optical media (CD, DVD and Blu-ray Disc) entered the market as a game changer^{11–13}. In the recent decade, an emerging type of non-volatile electronic memory utilizing PCMs has been developed and commercialized with superior device performance in switching speed, storage capacity and scalability^{14–19}. Thanks to the fast development of silicon waveguide platforms, PCM-based optical and photonic devices are gaining renewed attention, since they can go beyond the diffraction limit for high-density integration. Several advanced applications have been demonstrated, including non-volatile photonic memory²⁰⁻²⁴ , neurocomputing^{25–30}, flexible displays and morphic color rendering^{31–35}, metasurfaces and low-loss applications^{36–42}.

Two families of chalcogenide alloys have been used in commercial products, i.e., the pseudo-binary GeTe-Sb₂Te₃ alloys, in particular, Ge₂Sb₂Te₅ (GST)¹¹, and Ag and In doped Sb₂Te (AIST)¹². The major difference between these two families of alloys is the nucleation rate. The nucleation time for GST (of the order of nanoseconds)^{43–45} is more than three orders of magnitude faster than that of AIST (of order microseconds)^{46–48}. The difference in the crystallization mode (nucleation or growth) in binary Sb-Te system as a function of Sb:Te ratio was explained in ref.⁴⁹. In typical memory devices of sub-micrometer scale, the crystallization of GST occurs via incubation of multiple nuclei and subsequent grain growth (nucleation-type), while AIST typically crystallizes via the forefront of amorphous/crystalline interfaces (growth-type). Upon device miniaturization, crystallization of

growth-type PCMs can also be completed in nanoseconds level, because of the high interface growth rate^{48,50}; an example being doped Sb₂Te^{51,52}. Importantly, their crystallization process can be better controlled leading to superior programming consistencies, because of the absence of randomness associated with the stochastic nucleation process⁵³. Therefore, growth-type PCMs are attracting increasing attention for photonic applications recently^{54–56}.

Recently, it was shown that the crystallization temperature T_c of amorphous PCMs can be significantly increased by scaling the thickness down to a few nanometers, exploiting the nanoconfinement effects^{57–60}. Even amorphous Sb thin films (3 nm) can be stabilized at 20 °C over 50 h⁵⁷, in spite of the fact that the T_c of amorphous Sb is well below room temperature. In this way, doping is no longer compulsory to enhance the amorphous stability for practical applications. Here, we focus on the prototypical growth-dominated alloy Sb₂Te, which shows a fair T_c of ~150 °C⁶¹ in ~100 nm thick thin films. One can expect that in ultra-thin films of Sb₂Te (e.g., ~5 nm) the stability of the amorphous state will be further enhanced so as to make them suitable for most non-volatile photonic applications Importantly, the contrast in optical properties is mainly determined by the parent alloy, Sb₂Te, not by impurities⁵⁶. However, in-depth atomicscale understanding of Sb₂Te upon rapid crystallization at elevated temperatures is still lacking. In this work, we carry out multiscale simulations on Sb₂Te, including density functional (DFT) based ab initio molecular dynamics (AIMD) calculations and finitedifference time-domain (FDTD) simulations, to unveil the structural and optical evolution of Sb₂Te during ultrafast crystallization and subsequent thermal annealing. We reveal that amorphous Sb₂Te could crystallize into a disordered rhombohedral structure, showing rather different electronic and optical properties with respect to the A7 ground state. Our multiscale point towards

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Fig. 1 Structural evolution during simulated crystallization of Sb₂Te at ~ 600 K. a The most stable phase of Sb₂Te in fully ordered A7 structure with alternating Sb₂Te₃ and Sb₂ atomic blocks. **b** Snapshots of the crystallization process initiated by the amorphous/crystalline interface. The model is fully crystallized after 135 ps (denoted as "cryst."), resulting in a disordered structure with Te atoms randomly distributed in the bulk.

different strategies for device programming due to the formation of metastable crystalline Sb₂Te at the nanoscale.

RESULTS

Rapid crystallization and subsequent atomic ordering

The ground state of Sb₂Te is in rhombohedral A7 structure as shown in Fig. 1a. Its primitive cell is composed of one Sb₂Te₃ quintuple-layer and two Sb₂ bilayer blocks, which are alternately stacked and separated by van der Waals-like gaps. To obtain the crystallized structure via rapid crystal growth, we adopted a similar AIMD simulation protocol with fixed crystalline layers, as done in our previous work^{50,62}. We built a large model of crystalline Sb₂Te orthorhombic supercell with the of in an size $2.24 \times 2.16 \times 5.16$ nm³ (540 Sb atoms and 270 Te atoms). Each atomic layer has 30 atoms. One Sb layer and one Te layer were kept fixed during the melt-quench calculation. Specifically, the model was first randomized at 3000 K, and then guenched down to 1000 K in 6 ps. It was held at 1000 K for ~30 ps and then quenched to 300 K with a cooling rate of 25 K/ps to create a planar amorphous/crystalline interface. Subsequently, the model was reheated and annealed at ~600 K, and became fully crystallized in ~135 ps. See more technical details in the Methods section. Figure 1b shows some snapshots of the crystallization trajectory. Obviously, the crystallized structure is different from the fully ordered A7 structure, in that the Te atoms are not arranged in layers but scattered in the bulk, which can be attributed to the fast atomic diffusion and large sticking coefficients⁵⁰

We took several atomic configurations during the rapid growth process and quenched them down very rapidly down to zero K by direct geometry relaxation. These partially crystallized states are non-volatile, and could in principle be obtained in devices by sending weak or short pulses. The corresponding total energy of these intermediate states calculated at zero K is shown in Fig. 2a, indicating a continuous energy reduction by ~150 meV/atom. Yet, this crystallized state is still about ~65 meV/atom higher in energy as compared to the ground state A7 structure. Post annealing could in principle reduce this energy difference and drive the transformation to the more ordered ground state. This trend is consistent with the case of GST, where a metastable rocksalt-like phase containing high amount of atomic disorder is firstly formed upon nanoseconds crystallization, and is then gradually

transformed into an ordered trigonal phase (with a similar energy reduction of ~68 meV/atom) upon further long-term thermal annealing via vacancy ordering^{63–68}. Since the timescale of the post annealing process (minutes to hours) is beyond the reach of ab initio simulations, we manually swapped nearest-neighboring Sb and Te atoms to mimic the post annealing process, which can be regarded as a Te ordering process, i.e., the scattered Te in the bulk are rearranged into layers until the perfect ordered A7 structure is obtained. To quantify this structural ordering process, we define a parameter I_{Te} as the atomic concentration of Te atoms in the Te-rich layers. The larger the l_{Te} , the higher structural similarity with respect to A7 structure. More specifically, the model with fully random distribution of Te atoms corresponds to $I_{Te} = 33.3\%$, while that with fully ordered Te layers corresponds to $I_{Te} = 100\%$ (A7). The I_{Te} value of the crystallized structure is approximately 46.7%. Selected structures with different level of Te ordering can be found in Fig. 2c, in which the green stripes highlight the Te-rich layers. Clearly, the energy is gradually reduced upon Te ordering.

In comparison with our previous work on AIST⁵⁰, the crystallization simulation of the same size then (it took ~170 ps) is slower than Sb₂Te, due to the presence of dopants. The simulated crystallized phase of AIST was also in a disordered rhombohedral structure, consistent with experimental observation upon rapid laser irradiation⁶⁹. Atomic ordering into layered structures with clear separation of Sb₂Te₃ blocks with In and Ag impurities and Sb₂ slabs was also observed in AIST thin films upon long-term thermal annealing at elevated temperatures⁷⁰. Hence, our work resolves the discrepancy in experimental observations by separating the rapid crystallization process obtained on the nanosecond timescale with the subsequent atomic ordering in the crystalline phase upon long-term thermal annealing on the minute timescale. Next, we evaluated the impact of crystallization and Te ordering on dielectric function, which is important for optical applications using Sb₂Te-based alloys.

Evolution of optical properties

Next, we carried out DFT calculations to evaluate the change in optical properties during the crystallization and Te ordering process of Sb₂Te. All atomic structures were fully relaxed at zero K prior to these calculations. The obtained real (ε_1) and imaginary (ε_2) parts of the dielectric function are shown in Fig. 3a, b. The



Fig. 2 Energy profiles for the crystallization and subsequent Te ordering processes. a Energy profile for the crystallization process of Sb₂Te. The amorphous, crystallized and intermediate structures were optimized at zero K for energy data collection. **b** Energy profile for the Te ordering process after crystallization. All the energy data points were obtained at zero K. **c** Snapshots of Te ordering process. The models are generated by manually swapping nearest-neighboring Sb and Te atoms. I_{Te} indicates the concentration of Te atoms in the Te-rich layers highlighted by green stripes.



Fig. 3 Dielectric function. The real part (ε_1) and imaginary part (ε_2) of the dielectric function during (**a**) the crystallization process and (**b**) the Te ordering process. **c** The averaged ε_1 and ε_2 over the spectrum range of 1400–1800 nm and 400–800 nm.

spectrum is chosen to range from 400 to 2000 nm, covering the visible light for the non-volatile display application and the telecom wavelength for photonic memory/computing applications. As crystallization proceeds, ε_1 decreases in the whole spectrum, while ε_2 increases in the long wavelength region (1200–2000 nm) but slightly decreases in the visible light region

(400–800 nm). For the Te ordering process, both ε_1 and ε_2 show small variations in the visible light region but sizable changes in the long wavelength region. To see the trends more clearly, we averaged the ε_1 and ε_2 values in the range 400–800 nm and 1400–1800 nm for both crystallization and Te ordering process, as shown in Fig. 3c. The variation in the visible light range turns out



Fig. 4 Optical variations for random-swap models. a Example of a "random-swap" model with $l_{Te} = 86.7\%$. Red arrows highlight the random-swapping process between Sb/Te pairs. The swapped atoms that deviate from the fully ordered structure (Fig. 1a) are depicted with larger spheres. **b**–**e** Imaginary part of the dielectric function (ϵ_2), refractive index (n), extinction coefficient (k) and reflectivity (R) of the random-swap models ranging from $l_{Te} = 33.3\%$ to $l_{Te} = 100\%$. The data of the amorphous phase were added for a direct comparison.

to be smaller than that in the long wavelength region. It is interesting to note that the Te ordering process greatly reduces the optical contrast window between amorphous and crystallized states in the long wavelength region for both ε_1 and ε_2 . This behavior is different from that of GST alloys, whose vacancy ordering process after crystallization further enlarges the contrast window^{65,71}. However, the Te ordering process has a much smaller effect on the visible light region.

To further validate the optical variations for the Te ordering process, we built five independent models for each I_{Te} value by using a random number generator, and calculated their optical properties. The models were built by randomly swapping Sb/Te atomic pairs in the A7 structure (Fig. 4a), rather than only swapping the nearest-neighbor pairs (Fig. 2c). As shown in Fig. 4b and Supplementary Fig. 1, the dielectric function profiles of these five models are highly consistent with that shown in Fig. 3. The changes in dielectric functions have direct influences on the refractive index (*n*), extinction coefficient (*k*) and reflectivity coefficient (*R*) that are exploited for applications. These quantities were using the following equations⁷²:

$$n(\omega) = \left(\frac{\sqrt{\varepsilon_1^2 + \varepsilon_2^2} + \varepsilon_1}{2}\right)^{\frac{1}{2}},\tag{1}$$

$$k(\omega) = \left(\frac{\sqrt{\varepsilon_1^2 + \varepsilon_2^2} - \varepsilon_1}{2}\right)^{\frac{1}{2}},\tag{2}$$

$$R(\omega) = \frac{(n-1)^2 + k^2}{(n+1)^2 + k^2}.$$
(3)

As shown in Fig. 4c-e, these three optical profiles show smaller variations in the visible light region but much larger changes in the telecom band upon Te ordering process. This implies that the annealing process after crystallization should have a large impact

on the memory/computing applications, while probably a small influence on the non-volatile display applications.

To explain this trend, we plotted the total density of states (TDOS) profiles for each l_{Te} value in Fig. 5a. As the l_{Te} value decreases, the TDOS values from -1.0 to 0.5 eV (with respect to the Fermi energy, which is shifted as zero) increase, while the values within 0.5–1.0 eV become smaller. The TDOS profiles beyond these two regions show marginal variations. These findings are also confirmed by hybrid functional calculations, which generally give more accurate predictions of the electronic states near the Fermi energy (Supplementary Fig. 2). The same trend also holds for the optical calculations (Supplementary Fig. 3). The TDOS curves and the corresponding inverse participation ratio (IPR) values of all disordered models are included in Supplementary Figs. 4 and 5. Although the A7 phase is not a semiconductor, it shows a pseudo gap near the Fermi level. As the I_{Te} value decreases, this pseudo gap is gradually filled, resulting in more free carriers for light absorption in the disordered crystalline models (Fig. 4d). The change in TDOS is also mirrored in the joint density of states (JDOS), which is one of the key components for ε_2 , accounting for the amount of possible inter-band excitations. The other key component for ε_2 is the transition dipole moment (TDM), quantifying the transition probability for each possible excitation^{73–75}. As shown in Fig. 5b, the JDOS values increase with the reduction of l_{Te} in the long wavelength (low photon energy) region, which leads to the increase in ε_2 values. However, for the small wavelength (high photon energy) region, the JDOS curves are almost unaffected by variations in I_{Te} . Therefore, the decrease of ε_2 values in this region is expected to originate from the variations of TDM, which indeed decreases with the reduction of $I_{\rm Te}$ in the visible light regime (Fig. 5c).

Furthermore, we investigated the structural origin for the variation of the TDOS profiles. We plotted the partial DOS (PDOS) per atom for both Te and Sb atoms in Fig. 6a, showing similar trend as the TDOS in Fig. 5a. This indicates that both types of atoms contribute to the variations of the electronic structure. The PDOS curves of all disordered models are included in



Fig. 5 Electronic structure of random-swap models. a–c Total density of states (TDOS), joint density of states (JDOS) and transition dipole moment (TDM) of the random-swap models ranging from $l_{Te} = 33.3\%$ to $l_{Te} = 100\%$.



Fig. 6 Relationship between atomic structure and electronic structure. a Partial density of states (PDOS) per atom for Te and Sb atoms upon Te ordering. **b** Local density of states (LDOS) in terms of the coordination number CN_{Te} for a model with $l_{Te} = 86.7\%$ and the perfect A7 model. The shaded areas and solid curves are the envelope and averaged LDOS of all the atoms with the same CN_{Te} , respectively. Note that the CN_{Te} value for Te atoms equals zero in the A7 model. **c** Models of A7 and $l_{Te} = 86.7\%$ with atomic bonds being highlighted. For the latter model, only Te–Te homopolar bonds are shown.

Supplementary Fig. 4. We selected the $l_{Te} = 86.7\%$ model as an example, and further analyzed the local DOS (LDOS) of all the atoms in terms of their coordination environment, as shown in Fig. 6b. We defined CN_{Te} as the number of Te atoms surrounding the center atom, see Fig. 6c. The CN_{Te} value is zero for all the Te atoms, and is either 0 (within the Sb₂ slabs), 3 (at the interface) or 6 (within the Sb₂Te₃ block) for Sb atoms in the ordered A7

structure. However, for the disordered structures, such as the structure of the $l_{Te} = 86.7\%$, the CN_{Te} value can range from 0 to 6 for both Te and Sb atoms (Supplementary Fig. 6). In this model, a clear increase in LDOS at and above the Fermi level is observed as CN_{Te} increases for both Te and Sb atoms. The trend is stronger for Te atoms because more valence electrons can be found locally due to the enriched Te–Te bonds⁶². This behavior is also reflected

in the calculated IPR values (Supplementary Fig. 5). Regarding the A7 model with no Te–Te bonds, the LDOS for Te atoms is nearly vanished at the Fermi level, similar to the case of $CN_{Te} = 0$ of the disordered model. While for Sb atoms, there are three neighboring configurations, which show a nearly vanishing LDOS at the Fermi level (comparable to $CN_{Te} = 0$ of the disordered model) but a sizeable LDOS around 0.5 eV (appearing between $CN_{Te} = 3$ and 6 of the disordered model).

Non-volatile display devices

We then propose two potential photonic applications of Sb₂Te using FDTD simulations (see Methods)⁷⁶. So far, optical experiments of Sb₂Te are still limited, and it also remains unclear whether a metastable configuration can be obtained upon rapid crystallization using femtosecond or picosecond laser pulses. Hence, we used the calculated n, k and R from ab initio simulations as the input parameters for the FDTD simulations. First, we consider non-volatile display applications. Figure 7a shows the schematic of a reflective display thin-film device, incorporating indium tin oxide (ITO)/Sb₂Te/ITO multilayer on top of a silver mirror coated on a glass substrate. The thickness of each layer has been chosen to enhance the color contrast between the amorphous and crystalline phases. Specifically, h_{ITO1} , h_{Sb2Te} , h_{ITO2} are 10, 15, 130 nm, respectively. These thin films can generate resonant reflections based on the optical cavity effect³¹, which are determined by the phase of the Sb₂Te thin film in the cavity. Figure 7b shows the simulated reflectance spectra of the designed thin-film device with the amorphous (amor.), crystallized (cryst.) and fully ordered (A7) Sb₂Te. Obviously, the reflectance curves of crystallized and fully ordered structures almost overlap, differing notably from that of the amorphous phase. As shown in Fig. 7c, we mapped the reflectance spectra onto the CIE1931 chromaticity diagram by using the CIE color-matching equation⁷⁷, and showed that the colors of the two crystalline structures are indeed close to each other. We further converted the spectra to the RGB color code⁷⁷, and simulated the university logo encoded on the multilayer devices as shown in Fig. 7d, e, exhibiting excellent display performance. Such display application can be realized by either electrical pulse stimulation or laser direct write^{31–34}, and a recent study has demonstrated experimentally that Sb₂Te thin films can be used for color rendering⁵⁵. Our simulations suggest that further thermal annealing of the crystallized phase would not alter the encoded color significantly, which guarantees the robustness of the display performance.

Waveguide devices for photonic memory and computing

Another potential application for Sb₂Te is the photonic memory and computing. Figure 8a shows the schematic of a silicon-on-insulator (SOI) strip waveguide decorated with Sb₂Te and ITO thin films. ITO is a protection layer used to prevent oxidation of Sb₂Te. Thickness and width of the SOI waveguide are denoted as h_{wg} and w_{wg} , respectively, and those of the Sb₂Te (ITO) thin film are denoted as h_{Sb2Te} and d_{Sb2Te} (h_{ITO} and d_{ITO}). Transmittance (T) of light passing through the waveguide device is P_2/P_1 , where P_1 and P_2 are the power of incident and transmitted light, respectively. We investigated transmittance of light with two sets of geometrical parameters: $h_{wg} = 0.34 \,\mu\text{m}, \quad w_{wg} = 0.5 \,\mu\text{m}, \quad h_{\text{Sb2Te}} = 5 \,\text{nm}, \quad h_{\text{ITO}} = 10 \,\text{nm}, \text{ and}$ $d_{\text{Sb2Te}} = d_{\text{ITO}} = 2 \text{ or } 1 \mu \text{m}$. The incident light is with the fundamental transverse magnetic (TM) mode and a wavelength range of 1500-1600 nm. Figure 8b shows the transmission spectra of the Sb₂Te waveguide device with varied phases. Specifically, at a wavelength of 1560 nm, waveguide transmittances are respectively 25.03%, 0.96%, and 11.31% for the amorphous, crystallized, and A7 phases for the device with $d_{Sb2Te} = 2 \,\mu m$. These values can be further enlarged by reducing d_{Sb2Te} to 1 µm, giving 50.30%, 9.31%, and 33.90%, respectively.

The contrast window of the transmittance between the amorphous and crystallized phases can reach 40% for Sb₂Te, which is larger than that of the devices based on GST alloys ($\sim 20\%$)²¹, showing its potential for photonic memory and computing. As compared with the amorphous and fully ordered phases, the largely reduced output light intensity of the crystallized state is due to its much higher light absorption (larger *k*), which is also mirrored in the simulated electric field |*E*| profiles in Fig. 8c–e. Importantly, we note that upon further annealing after crystallization, the contrast window of transmittance is not



Fig. 7 Multilayer thin film display. a Schematic of a reflective display thin-film device, incorporating ITO/Sb₂Te/ITO multilayer on top of a silver mirror coated on a glass substrate. **b** Simulated reflectance spectra of the thin-film device in the amorphous (amor.), crystallized (cryst.) and fully ordered (A7) states. h_{ITO1} , h_{SbTe} and h_{ITO2} are 10, 15, 130 nm, respectively. **c** Color mapping of the three states on the CIE1931 chromaticity diagram. **d**, **e** Display of the university logo by exploiting the amorphous and crystallized states.

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Fig. 8 Photonic waveguide memory. a Schematic of a SOI strip waveguide decorated with Sb₂Te and ITO thin films. **b** Transmission spectra of the waveguide device in the amorphous (amor.), crystallized (cryst.) and fully ordered (A7) states, with the length of Sb₂Te patch (d_{Sb2Te}) equal to 2 or 1 µm. **c–e** Simulated electric field |*E*| profiles of the amor, cryst., and A7 states, respectively.

enlarged but reduced as highlighted by the arrows in Fig. 8b, which is different from the case of GST alloys⁷¹. Moreover, the geometrical parameters of the waveguide device can be further optimized to enhance the on-off ratio of the light transmission, which is desirable for practical applications. It is also noted that the sizable contrast in optical properties between the metastable rocksalt phase and the stable hexagonal phase of GST or Sb₂Te₃ alloys has been utilized for non-volatile optical applications^{78–80}, which could in principle bypass the aging issues of the amorphous phase⁸¹. It remains to be explored whether the relatively large change in transmittance between the crystallized and A7 structure of Sb₂Te with $d_{Sb2Te} = 1 \,\mu m$ can also be exploited for optical applications.

DISCUSSION

We found that the atomic structure of crystalline Sb₂Te obtained after ultrafast crystallization is a disordered A7 structure with Te atoms randomly distributed in the bulk. The crystallized structure can be further annealed to induce a tellurium ordering process, and gradually transformed to a fully ordered structure with all the Te atoms forming perfect layers in the Sb₂Te₃ blocks. The structural difference between the rapidly crystallized and post annealed structures leads to a difference in electronic structure and thereby wavelength-dependent variations of the optical properties, i.e., it has notable influence in the telecom region, but negligible influence in the visible light region. Our multiscale simulations suggest that once programmed, the Sb₂Te-based display devices are insensitive to potential temperature fluctuations in the crystalline phase. In the ultrascaled devices of a few nm thickness, structural relaxation of the amorphous phase is also prohibited⁷. Therefore, Sb₂Te-based alloys could potentially lead to superior device performance for photonic applications that utilize the visible-light range. Regarding the memory/computing applications that rely on the telecom band, we suggest that additional temperature rise should be avoided after programming, and high-speed and high-frequency device operations could be desirable to gain the large programming window for Sb₂Te-based devices. Our work showcases how atomic understanding of materials can guide device design, and is expected to stimulate future exploration of Sb₂Te-based alloys for various photonic phase-change applications.

METHODS

Ab initio calculations

We carried out DFT-based ab initio molecular dynamics (AIMD) simulations by using the second-generation Car-Parrinello molecular dynamics scheme⁸² as implemented in the CP2K package⁸³. A triple-zeta plus polarization Gaussian-type basis set was used to expand the Kohn-Sham orbitals, and plane waves with a cutoff of 300 Ry were used to expand the charge density. Scalar-relativistic Goedecker-Teter-Hutter (GTH) pseudopotentials⁸⁴ and Perdew-Burke-Ernzerhof (PBE) functional⁸⁵ were applied in the calculations. The simulations were conducted in the canonical ensemble (NVT), and the temperature was controlled by a stochastic Langevin thermostat with the time step of 2 fs. The Vienna Ab-initio Simulation Package (VASP)⁸⁶ was used to compute the dielectric functions after structural relaxation of the models. PBE functional and PAW pseudopotentials⁸⁷ were used with the energy cutoff value set as 400 eV. I point was used to sample the Brillouin zone of the models with 810 atoms. The frequency-dependent dielectric matrix was calculated within the independent-particle approximation. Neglecting local field effects and many body effects was proven to be adequate to quantify the optical contrast between crystalline and amorphous PCMs⁷³⁻⁷⁵.

FDTD simulations

The reflective display thin-film device was modeled by 2D FDTD simulation (Lumerical FDTD Solutions)⁷⁶. Build-in models of refractive indices were used for silver, glass, and silicon. The light source is a plane wave (placed at $z = 1 \mu m$) with the propagation direction along -z axis, which is perpendicular to the thin-film surface. A monitor was placed above the light source (at $z = 1.5 \,\mu\text{m}$) to detect reflectance spectra. Perfectly matched layer (PML) boundary condition was applied at $z = \pm 2 \,\mu m$. Periodic boundary condition was applied for the rest boundaries. The symmetric geometry of the thin-film device enables polarizationinsensitive operation. The photonic waveguide memory devices were modeled by 3D FDTD with the fundamental transverse magnetic (TM) mode injected into a waveguide. A light source was placed at $x = -0.5 \,\mu\text{m}$ and a monitor was placed at $x = 4 \,\mu\text{m}$ to detect transmission spectra. PML boundary condition was applied to all boundaries. 3D FDTD simulation also calculated electric field profiles |E| at y = 0 plane. The grid sizes were set fine enough to

obtain converged simulation results. Especially, Δz was set as 1 nm for the Sb₂Te and ITO thin films.

DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author, Professor Wei Zhang (email: wzhang0@mail.xjtu.edu.cn), upon reasonable request.

CODE AVAILABILITY

The authors declare that the applied software supporting the findings of this study are commercially available in the VASP software package https://www.vasp.at and Lumerical FDTD Solutions https://www.ansys.com/products/photonics/fdtd.

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REFERENCES

- Wuttig, M. & Yamada, N. Phase-change materials for rewriteable data storage. Nat. Mater. 6, 824–832 (2007).
- 2. Wong, H.-S. P. et al. Phase change memory. Proc. IEEE 98, 2201 (2010).
- Zhang, W., Mazzarello, R., Wuttig, M. & Ma, E. Designing crystallization in phasechange materials for universal memory and neuro-inspired computing. *Nat. Rev. Mater.* 4, 150–168 (2019).
- Zhang, W., Mazzarello, R. & Ma, E. Phase-change materials in electronics and photonics. MRS Bull. 44, 686–690 (2019).
- Wuttig, M., Bhaskaran, H. & Taubner, T. Phase-change materials for non-volatile photonic applications. *Nat. Photonics* 11, 465–476 (2017).
- Wright, D., Bhaskaran, H. & Pernice, W. Integrated phase-change photonic devices and systems. MRS Bull. 44, 721–725 (2019).
- Zhang, W. & Ma, E. Unveiling the structural origin to control resistance drift in phase-change memory materials. *Mater. Today* 41, 156–176 (2020).
- Xu, M. et al. Recent advances on neuromorphic devices based on chalcogenide phase-change materials. Adv. Funct. Mater. 30, 2003419 (2020).
- 9. Yang, Z. et al. Designing conductive-bridge phase-change memory to enable ultralow programming power. Adv. Sci. 9, 2103478 (2022).
- Wang, J.-J. et al. Tailoring the oxygen concentration in Ge-Sb-O alloys to enable femtojoule-level phase-change memory operations. *Mater. Futures* 1, 045302 (2022).
- Yamada, N., Ohno, E., Nishiuchi, K., Akahira, N. & Takao, M. Rapid-phase transitions of GeTe-Sb2Te3 pseudobinary amorphous thin films for an optical disk memory. J. Appl. Phys. 69, 2849–2856 (1991).
- Iwasaki, H. et al. Completely erasable phase-change optical disc. II. application of Ag-In-Sb-Te mixed-phase system for rewritable compact disc compatible with CDvelocity and double CD-velocity. *Jpn. J. Appl. Phys. Part* 1 32, 5241–5247 (1993).
- Yamada, N. & Matsunaga, T. Structure of laser-crystallized Ge2Sb2+xTe5 sputtered thin films for use in optical memory. J. Appl. Phys. 88, 7020–7028 (2000).
- Fong, S. W., Neumann, C. M. & Wong, H.-S. P. Phase-change memory—towards a storage-class memory. *IEEE Trans. Electron. Dev.* 64, 4374–4385 (2017).
- Li, X. et al. Enhancing performances of phase change memory for embedded applications. *Phys. Status Solidi RRL* 13, 1800558 (2019).
- Rao, F. et al. Reducing the stochasticity of crystal nucleation to enable subnanosecond memory writing. *Science* 358, 1423–1427 (2017).
- Wang, X.-P. et al. Time-dependent density-functional theory molecular-dynamics study on amorphization of Sc-Sb-Te alloy under optical excitation. *npj Comput. Mater.* 6, 31 (2020).
- 18. Sun, L. et al. Ab initio molecular dynamics and materials design for embedded phase-change memory. *npj Comput. Mater.* **7**, 29 (2021).
- Xu, M., Xu, M. & Miao, X. Deep machine learning unravels the structural origin of mid-gap states in chalcogenide glass for high-density memory integration. *InfoMat* 4, e12315 (2022).
- Ríos, C., Hosseini, P., Wright, C. D., Bhaskaran, H. & Pernice, W. H. On-chip photonic memory elements employing phase-change materials. *Adv. Mater.* 26, 1372–1377 (2014).
- Ríos, C. et al. Integrated all-photonic non-volatile multi-level memory. Nat. Photon. 9, 725–732 (2015).
- 22. Cheng, Z. et al. Device-level photonic memories and logic applications using phase-change materials. *Adv. Mater.* **30**, 1802435 (2018).
- Zhou, W. et al. Phase-change materials for energy-efficient photonic memory and computing. MRS Bull. 47, 502–510 (2022).

- Wang, Y., Ning, J., Lu, L., Bosman, M. & Simpson, R. E. A scheme for simulating multi-level phase change photonics materials. *npj Comput. Mater.* 7, 183 (2021).
- Cheng, Z., Ríos, C., Pernice, W. H. P., Wright, C. D. & Bhaskaran, H. On-chip photonic synapse. *Sci. Adv.* 3, e1700160 (2017).
- Ríos, C. et al. In-memory computing on a photonic platform. Sci. Adv. 5, eaau5759 (2019).
- Feldmann, J., Youngblood, N., Wright, C. D., Bhaskaran, H. & Pernice, W. H. P. Alloptical spiking neurosynaptic networks with self-learning capabilities. *Nature* 569, 208–214 (2019).
- Shastri, B. J. et al. Photonics for artificial intelligence and neuromorphic computing. *Nat. Photon.* 15, 102–114 (2021).
- Feldmann, J. et al. Parallel convolutional processing using an integrated photonic tensor core. *Nature* 589, 52–58 (2021).
- Zhou, W. et al. In-memory photonic dot-product engine with electrically programmable weight banks. Nat. Commun. 14, 2887 (2023).
- Hosseini, P., Wright, C. D. & Bhaskaran, H. An optoelectronic framework enabled by low-dimensional phase-change films. *Nature* 511, 206–211 (2014).
- Rios, C., Hosseini, P., Taylor, R. A. & Bhaskaran, H. Color depth modulation and resolution in phase-change material nanodisplays. *Adv. Mater.* 28, 4720–4726 (2016).
- Carrillo, S. G. C. et al. A nonvolatile phase-change metamaterial color display. Adv. Opt. Mater. 7, 1801782 (2019).
- Tao, S. et al. Phase change materials for nonvolatile, solid-state reflective displays: from new structural design rules to enhanced color-changing performance. Adv. Opt. Mater. 8, 2000062 (2020).
- Gholipour, B. et al. Phase-change-driven dielectric-plasmonic transitions in chalcogenide metasurfaces. NPG Asia Mater. 10, 533–539 (2018).
- Li, P. et al. Reversible optical switching of highly confined phonon-polaritons with an ultrathin phase-change material. *Nat. Mater.* 15, 870–875 (2016).
- Zhang, Y. et al. Broadband transparent optical phase change materials for highperformance nonvolatile photonics. *Nat. Commun.* 10, 4279 (2019).
- Zhang, H. et al. Miniature multilevel optical memristive switch using phase change material. ACS Photonics 6, 2205–2212 (2019).
- Wang, Q. et al. Optically reconfigurable metasurfaces and photonic devices based on phase change materials. *Nat. Photonics* **10**, 60–65 (2016).
- Tian, J. et al. Active control of anapole states by structuring the phase-change alloy Ge2Sb2Te5. Nat. Commun. 10, 396 (2019).
- Zhang, Y. et al. Electrically reconfigurable non-volatile metasurface using low-loss optical phase-change material. *Nat. Nanotechnol.* 16, 661–666 (2021).
- Fang, Z. et al. Ultra-low-energy programmable non-volatile silicon photonics based on phase-change materials with graphene heaters. *Nat. Nanotechnol.* 17, 842–848 (2022).
- 43. Loke, D. et al. Breaking the speed limits of phase-change memory. *Science* **336**, 1566–1569 (2012).
- Lee, T. H. & Elliott, S. R. Ab Initio computer simulation of the early stages of crystallization: application to Ge2Sb2Te5 phase-change materials. *Phys. Rev. Lett.* **107**, 145702 (2011).
- Kalikka, J., Akola, J. & Jones, R. O. Crystallization processes in the phase change material Ge2Sb2Te5: unbiased density functional/molecular dynamics simulations. *Phys. Rev. B* 94, 134105 (2016).
- Lee, B. S. et al. Observation of the role of subcritical nuclei in crystallization of a glassy solid. *Science* 326, 980–984 (2009).
- Matsunaga, T. et al. From local structure to nanosecond recrystallization dynamics in AgInSbTe phase-change materials. *Nat. Mater.* 10, 129–134 (2011).
- Salinga, M. et al. Measurement of crystal growth velocity in a melt-quenched phase-change material. *Nat. Commun.* 4, 2371 (2013).
- Ahmed, S. et al. Change in structure of amorphous Sb-Te phase-change materials as a function of stoichiometry. *Phys. Status Solidi RRL* 15, 2100064 (2021).
- Zhang, W. et al. How fragility makes phase-change data storage robust: insights from ab initio simulations. Sci. Rep. 4, 6529 (2014).
- Lankhorst, M. H. R., Ketelaars, B. W. & Wolters, R. A. Low-cost and nanoscale nonvolatile memory concept for future silicon chips. *Nat. Mater.* 4, 347–352 (2005).
- van Pieterson, L., Lankhorst, M. H. R., van Schijndel, M., Kuiper, A. E. T. & Roosen, J. H. J. Phase-change recording materials with a growth-dominated crystallization mechanism: a materials overview. *J. Appl. Phys.* 97, 083520 (2005).
- Sebastian, A. et al. Tutorial: brain-inspired computing using phase-change memory devices. J. Appl. Phys. 124, 111101 (2018).
- Zhou, W. et al. Artificial biphasic synapses based on nonvolatile phase-change photonic memory cells. *Phys. Status Solidi RRL* 16, 2100487 (2022).
- Tao, W. et al. High optical/color contrast of Sb2Te thin film and its structural origin. *Mater. Sci. Semicond. Process.* 144, 106619 (2022).
- 56. Ahmed, S. et al. Unraveling the optical contrast in Sb2Te and AgInSbTe phasechange materials. J. Phys. Photonics **3**, 03401 (2021).
- Salinga, M. et al. Monatomic phase change memory. Nat. Mater. 17, 681–685 (2018).

D

- Zhang, W. & Ma, E. Single-element glass to record data. *Nat. Mater.* 17, 654–655 (2018).
- 59. Jiao, F. et al. Monatomic 2D phase-change memory for precise neuromorphic computing. *Appl. Mater. Today* **20**, 100641 (2020).
- 60. Wang, X. P. et al. Phase-change-memory process at the limit: a proposal for utilizing monolayer Sb2Te3. *Adv. Sci.* **8**, 2004185 (2021).
- Hu, J. et al. Cr-doped Sb2Te materials promising for high performance phasechange random access memory. J. Alloys Compd. 908, 164593 (2022).
- Xu, Y.-Z. et al. Unraveling crystallization mechanisms and electronic structure of phase-change materials by large-scale ab initio simulations. *Adv. Mater.* 34, 2109139 (2022).
- Wang, J.-J., Xu, Y.-Z., Mazzarello, R., Wuttig, M. & Zhang, W. A review on disorderdriven metal-insulator transition in crystalline vacancy-rich GeSbTe phase-change materials. *Materials* **10**, 862 (2017).
- Zhang, B. et al. Element-resolved atomic structure imaging of rocksalt Ge2Sb2Te5 phase-change material. *Appl. Phys. Lett.* **108**, 191902 (2016).
- Siegrist, T. et al. Disorder-induced localization in crystalline phase-change materials. *Nat. Mater.* 10, 202–208 (2011).
- Zhang, W. et al. Role of vacancies in metal-insulator transitions of crystalline phase-change materials. *Nat. Mater.* 11, 952–956 (2012).
- Zhang, W., Wuttig, M. & Mazzarello, R. Effects of stoichiometry on the transport properties of crystalline phase-change materials. *Sci. Rep.* 5, 13496 (2015).
- 68. Bragaglia, V. et al. Metal-insulator transition driven by vacancy ordering in GeSbTe phase change materials. *Sci. Rep.* **6**, 23843 (2016).
- Matsunaga, T., Umetani, Y. & Yamada, N. Structural study of a Ag3.4ln3.7Sb76.4Te16.5 quadruple compound utilized for phase-change optical disks. *Phys. Rev. B* 64, 184116 (2001).
- Zhu, M. et al. Direct atomic insight into the role of dopants in phase-change materials. *Nat. Commun.* 10, 3525 (2019).
- Bi, C. et al. Three distinct optical-switching states in phase-change materials containing impurities: from physical origin to material design. *J. Mater. Sci. Technol.* **75**, 118–125 (2021).
- Wang, V., Xu, N., Liu, J.-C., Tang, G. & Geng, W.-T. VASPKIT: a user-friendly interface facilitating high-throughput computing and analysis using VASP code. *Comput. Phys. Commun.* 267, 108033 (2021).
- 73. Wełnic, W., Botti, S., Reining, L. & Wuttig, M. Origin of the optical contrast in phase-change materials. *Phys. Rev. Lett.* **98**, 236403 (2007).
- Caravati, S., Bernasconi, M. & Parrinello, M. First principles study of the optical contrast in phase change materials. J. Phys. Condens. Matter. 22, 315801 (2010).
- Wang, X., Shen, X., Sun, S. & Zhang, W. Tailoring the structural and optical properties of germanium telluride phase-change materials by indium incorporation. *Nanomaterials* **11**, 3029 (2021).
- 76. Lumerical Solutions, Inc. https://www.ansys.com/products/photonics/fdtd.
- Levkowitz, H. Color theory and modeling for computer graphics, visualization, and multimedia applications. (Springer Science & Business Media, Springer New York, 1997).
- Hu, C. et al. "All-crystalline" phase transition in nonmetal doped germanium-antimony-tellurium films for high-temperature non-volatile photonic applications. *Acta Mater.* 188, 121–130 (2020).
- Jiang, T.-T. et al. In situ characterization of vacancy ordering in Ge-Sb-Te phasechange memory alloys. Fundam. Res. https://doi.org/10.1016/j.fmre.2022.1009.1010 (2022).
- Zhang, W. et al. Metavalent bonding in layered phase-change memory materials. *Adv. Sci.* 10, 2300901 (2023).
- Raty, J.-Y. et al. Aging mechanisms of amorphous phase-change materials. *Nat. Commun.* 6, 7467 (2015).
- Kühne, T., Krack, M., Mohamed, F. & Parrinello, M. Efficient and accurate Car-Parrinello-like approach to born-Oppenheimer molecular dynamics. *Phys. Rev. Lett.* 98, 066401 (2007).
- Hutter, J., Iannuzzi, M., Schiffmann, F. & VandeVondele, J. cp2k:atomistic simulations of condensed matter systems. WIREs Comput. Mol. Sci. 4, 15–25 (2014).

- Goedecker, S., Teter, M. & Hutter, J. Separable dual-space Gaussian pseudopotentials. *Phys. Rev. B* 54, 1703 (1996).
- Perdew, J. P., Burke, K. & Ernzerhof, M. Generalized gradient approximation made simple. *Phys. Rev. Lett.* 77, 3865–3868 (1996).
- Kresse, G. & Hafner, J. Ab initio molecular dynamics for liquid metals. *Phys. Rev. B* 47, 558–561 (1993).
- Kresse, G. & Joubert, D. From ultrasoft pseudopotentials to the projector augmented-wave method. *Phys. Rev. B* 59, 1758 (1999).

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AUTHOR CONTRIBUTIONS

X.-D.W. and W.Zhou contributed equally to this work. W.Zhang conceptualized the work. The ab initio simulations were performed by X.-D.W. with contributions from H.Z. and S.A. The FDTD simulations were performed by W.Zhou with contributions from T.H. The paper was written by X.-D.W., W.Zhou and W.Zhang with contributions from R.M. and E.M. All authors contributed to the discussions and analyses of the data, and approved the final version.

COMPETING INTERESTS

The authors declare no competing interests.

ADDITIONAL INFORMATION

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